

47 CFR PART 15B

TEST REPORT

of

EVDO Rev.A Data card

Brand Name: Haier
Model Name: HC-CE310
Report No.: SZ09090091E01
FCC ID.: SG70909HC-CE310

prepared for

Qingdao Haier Telecom Co.Ltd.

No.1, HaierRoad, Hi-tech Zone, Qingdao, 266101, P.R.China

prepared by

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Bluetooth®

CTIA Authorized Test Lab

LAB CODE 20081223-00

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1. TEST CERTIFICATION

Equipment under Test: EVDO Rev.A Data card

Brand Name: Haier

Model Name: HC-CE310

FCC ID: SG70909HC-CE310

Applicant: Qingdao Haier Telecom Co.Ltd.

No.1, HaierRoad, Hi-tech Zone, Qingdao, 266101, P.R.China

Manufacturer: Haier

No.1, HaierRoad, Hi-tech Zone, Qingdao, 266101, P.R.China

Emission Designator 1M25F9W

Test Standards: 47 CFR Part 15 Subpart B

Test Date(s): September 28, 2009 - October 16, 2009

Test Result: PASS

* We Hereby Certify That:

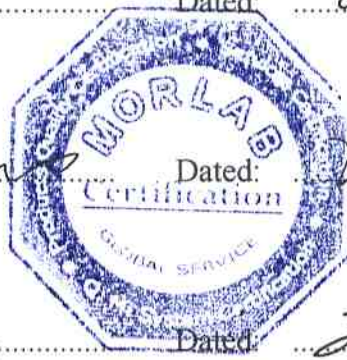
The equipment under test was tested by Shenzhen Electronic Product Quality Testing Center Morlab Laboratory. The test data, data evaluation, test procedures and equipment configurations shown in this report were made in accordance with the requirement of related FCC rules.

The test results of this report only apply for the tested sample equipment identified above. The test report shall be invalid without all the signatures of the test engineer, the reviewer and the approver.

Tested by: Ni Yong Dated: 2009.10.19
Ni Yong

Reviewed by: Liao Jianming Dated: 2009.10.19
Liao Jianming

Approved by: Shu Luan Dated: 2009.10.19
Shu Luan



2. GENERAL INFORMATION

2.1 EUT Description

EUT Type: EVDO Rev.A Data card
Model Name: HC-CE310
Serial No.....: N/A
Hardware Version: SP
Software Version: R00.00.07
Modulation: CDMA 1X, EVDO Rev A
Frequency: Tx: 824.7 – 848.31 MHz; Rx: 869.7-893.31MHz

Note 1: The EUT is an EVDO Rev.A Data card support CDMA1X and EVDO. It can be used as a wireless module.

Note 2: The transmitter (Tx) frequency arrangement of the Band Class 0 used by the EUT can be represented with the formula $F(n) = 0.030 \cdot (n - 1023) + 825.000$, $991 \leq n \leq 1023$ and $F(n) = 0.030 \cdot n + 825.000$, $1 \leq n \leq 799$; the lowest, middle, highest channel numbers (ARFCHs) used and tested in this report are separately 1013 (824.7MHz), 384 (836.52MHz) and 777 (848.31MHz).

Note 3: The EUT can connect to PC via a special USB cable, the EUT is powered by the PC and driveled by the PC, the EUT can be used as a mass storage while equipped with a T-flash card, and can be used as a radio and MP3 with an earphone. For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

2.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15 (10-1-05 Edition)	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS

NOTE:

The tests were performed according to the method of measurements prescribed in ANSI C63.4 2003.

2.3 Facilities and Accreditations

2.3.1 Facilities

Shenzhen Electronic Product Quality Testing Center Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659.

All measurement facilities used to collect the measurement data are located at Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen 518055 CHINA. The test site is constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22; the FCC registration number is 741109.

2.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	20 - 25
Relative Humidity (%):	40 - 60
Atmospheric Pressure (kPa):	96

2.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	$\pm 1.8\text{dB}$
Uncertainty of Radiated Emission:	$\pm 3.1\text{dB}$

3. TEST CONDITIONS SETTING

3.1 Test Mode

1. Test Mode

- (1) The first test mode (CDMA1X)

The EUT configuration of the emission tests is EUT + PC.

During the measurement, the CDMA radio works normally.

During the measurement of Traffic operating mode, a communication link was established between the EUT and a System Simulator (SS). The EUT operated at CDMA 1X mid channel (384) and maximum output power (All Up Bit).

- (2) The second test mode (EVDO)

The EUT configuration of the emission tests is EUT + PC.

During the measurement, the two EVDO radio works normally.

During the measurement of Traffic operating mode, a communication link was established between the EUT and a System Simulator (SS). The EUT operated at EVDO mid channel (384) and maximum output power (All Up Bit).

- (3) The third test mode (idle)

The EUT configuration of the emission tests is EUT + PC.

In this test mode, the EUT was attached a System Simulator (SS). But no communication link was established.

- (4) The third test mode (MP3 or radio)

The EUT configuration of the emission tests is EUT + T-flash card + earphone.

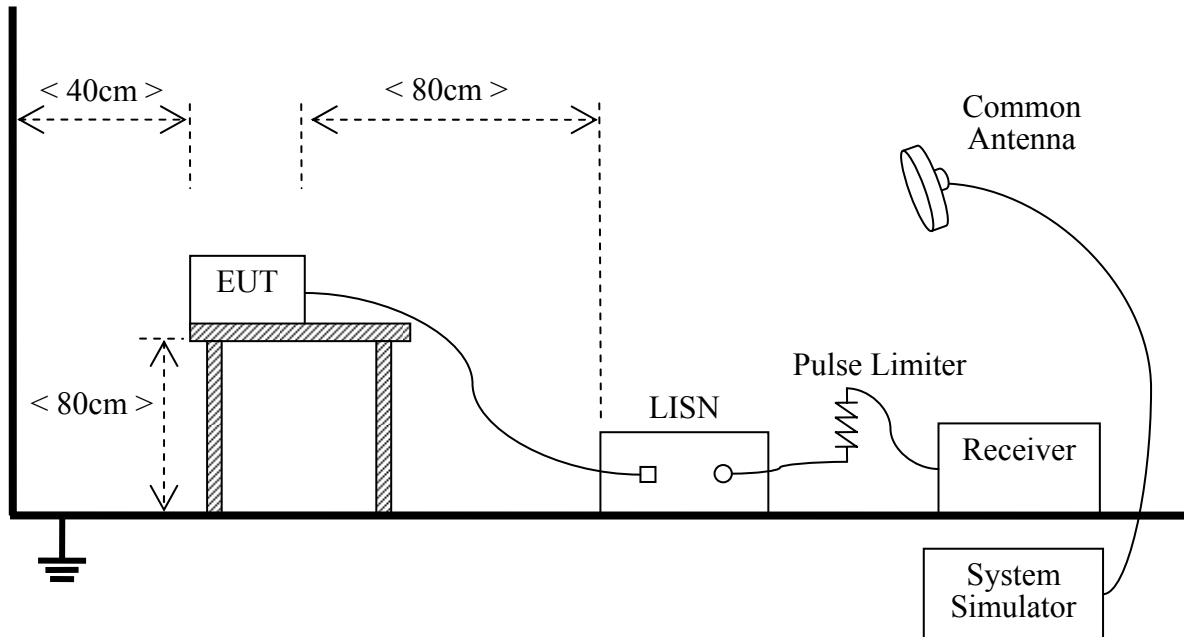
In this test mode, the EUT was worked as a MP3 or radio.

NOTE: All test modes are performed, only the worst cases are recorded in this report.

3.2 Test Setup and Equipments List

3.2.1 Conducted Emission

A. Test Setup:



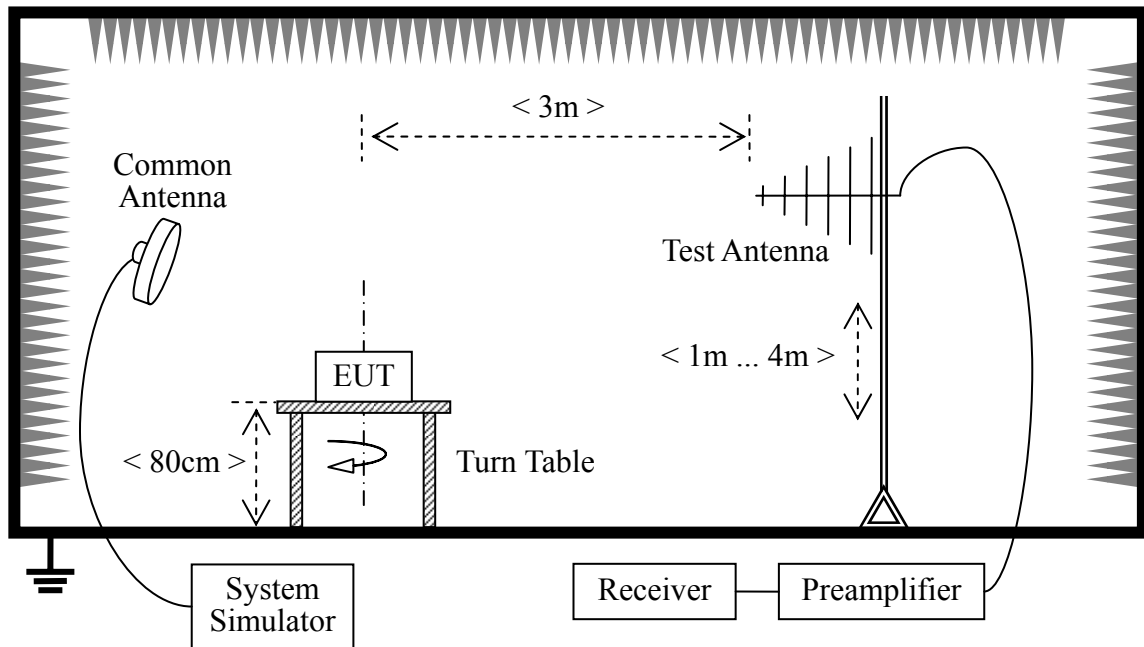
The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu\text{H}$ of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Receiver	Agilent	E7405A	US44210471	2009.08	1year
LISN	Schwarzbeck	NSLK 8127	812744	2009.08	1year
Pulse Limiter (20dB)	Schwarzbeck	VTSD 9561-D	9391	(n.a.)	(n.a.)
System Simulator	Agilent	E5515C	GB43130131	2009.08	1year
Personal Computer	IBM	IBM_T20	(n.a.)	(n.a.)	(n.a.)
Bluetooth-Headset	Nokia	HS-36W	(n.a.)	(n.a.)	(n.a.)
T-Flash Card	SanDisk	256MB	(n.a.)	(n.a.)	(n.a.)

3.2.2 Radiated Emission

C. Test Setup:



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower. The Common Antenna is used for the call between the EUT and the System Simulator (SS).

D. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Receiver	Agilent	E7405A	US44210471	2009.08	1year
Semi-Anechoic Chamber	Albatross	9m*6m*6m	(n.a.)	2009.08	2year
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-274	2009.08	1year
Test Antenna - Horn	Schwarzbeck	BBHA 9120C	9120C-384	2009.08	1year
System Simulator	Agilent	E5515C	GB43130131	2009.08	1year
Personal Computer	IBM	IBM_T20	(n.a.)	(n.a.)	(n.a.)
Bluetooth-Headset	Nokia	HS-36W	(n.a.)	(n.a.)	(n.a.)
T-Flash Card	SanDisk	256MB	(n.a.)	(n.a.)	(n.a.)

4. 47 CFR PART 15B REQUIREMENTS

4.1 Conducted Emission

4.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quai-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

4.1.2 Test Description

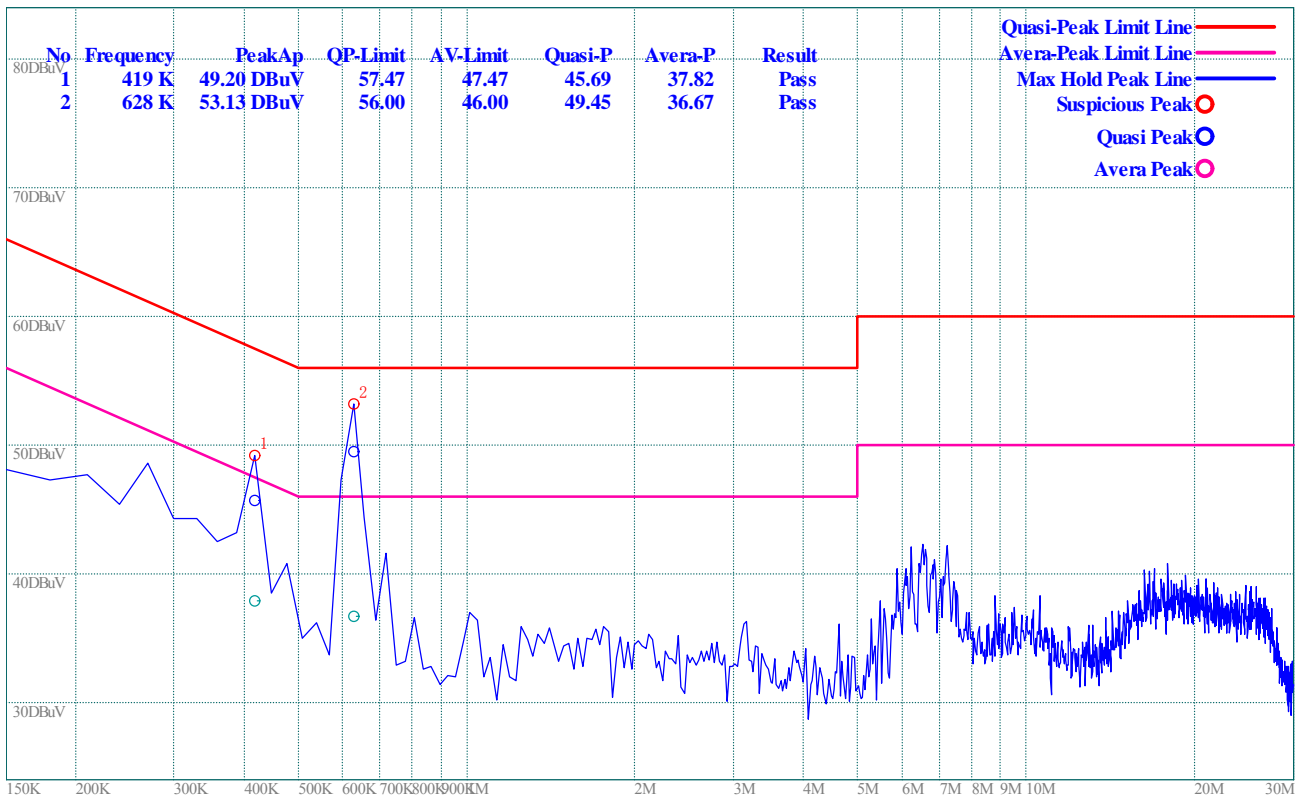
See section 3.2.1 of this report.

4.1.3 Test Result

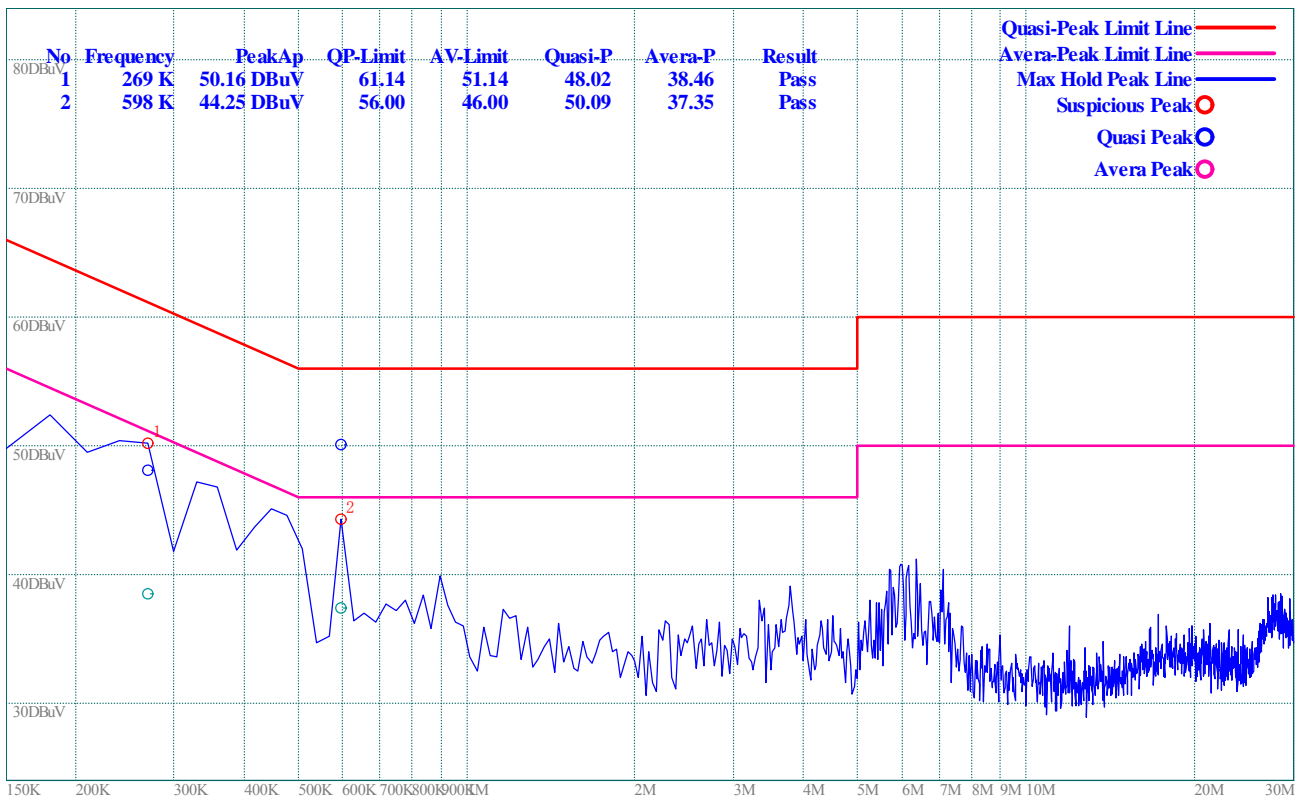
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

4.1.3.1 CDMA 1X Test Mode

A. Test Plot and Suspicious Points:



(Plot A: L Phase)



(Plot B: N Phase)

4.2 Radiated Emission

4.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength	
	$\mu\text{V/m}$	$\text{dB}\mu\text{V/m}$
30 - 88	100	40
88 - 216	150	43.5
216 - 960	200	46
Above 960	500	54

NOTE:

- a) Field Strength ($\text{dB}\mu\text{V/m}$) = $20 \cdot \log[\text{Field Strength } (\mu\text{V/m})]$.
- b) In the emission tables above, the tighter limit applies at the band edges.

4.2.2 Test Description

See section 3.2.2 of this report.

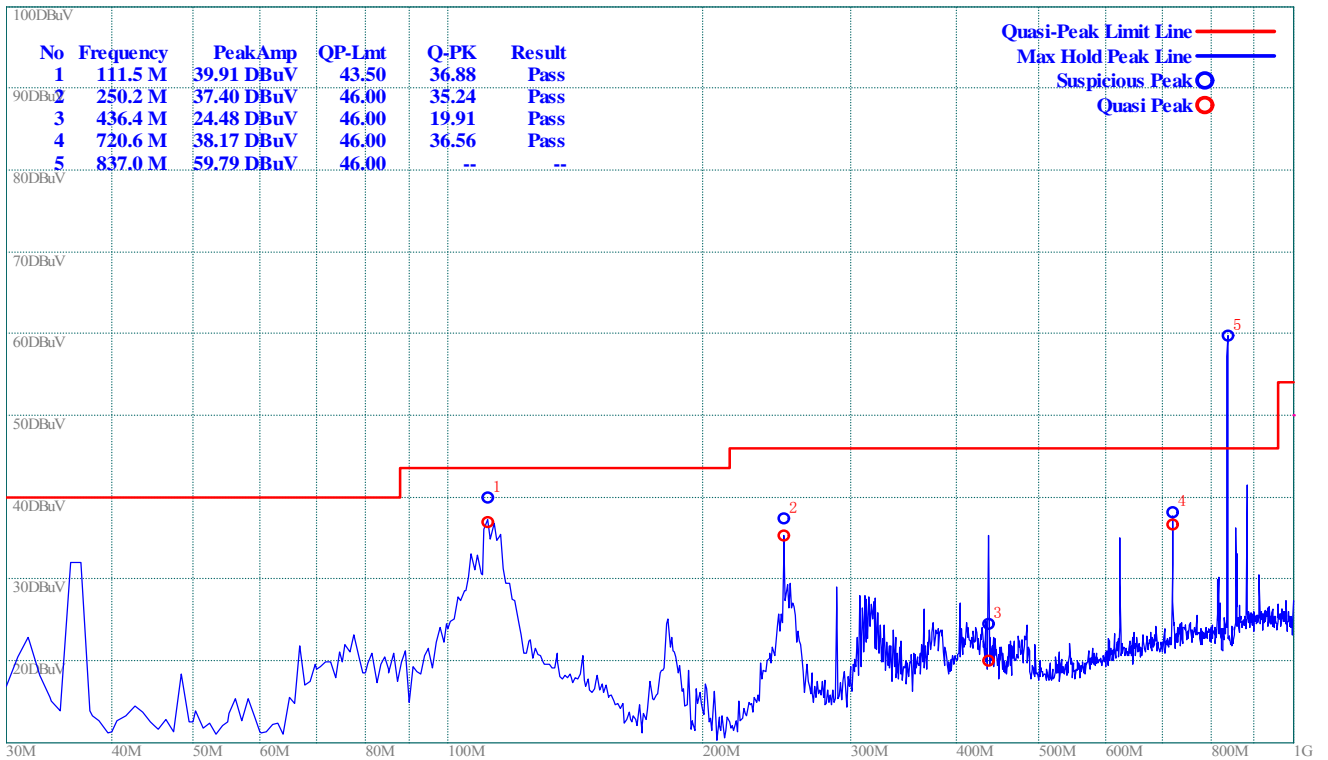
4.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

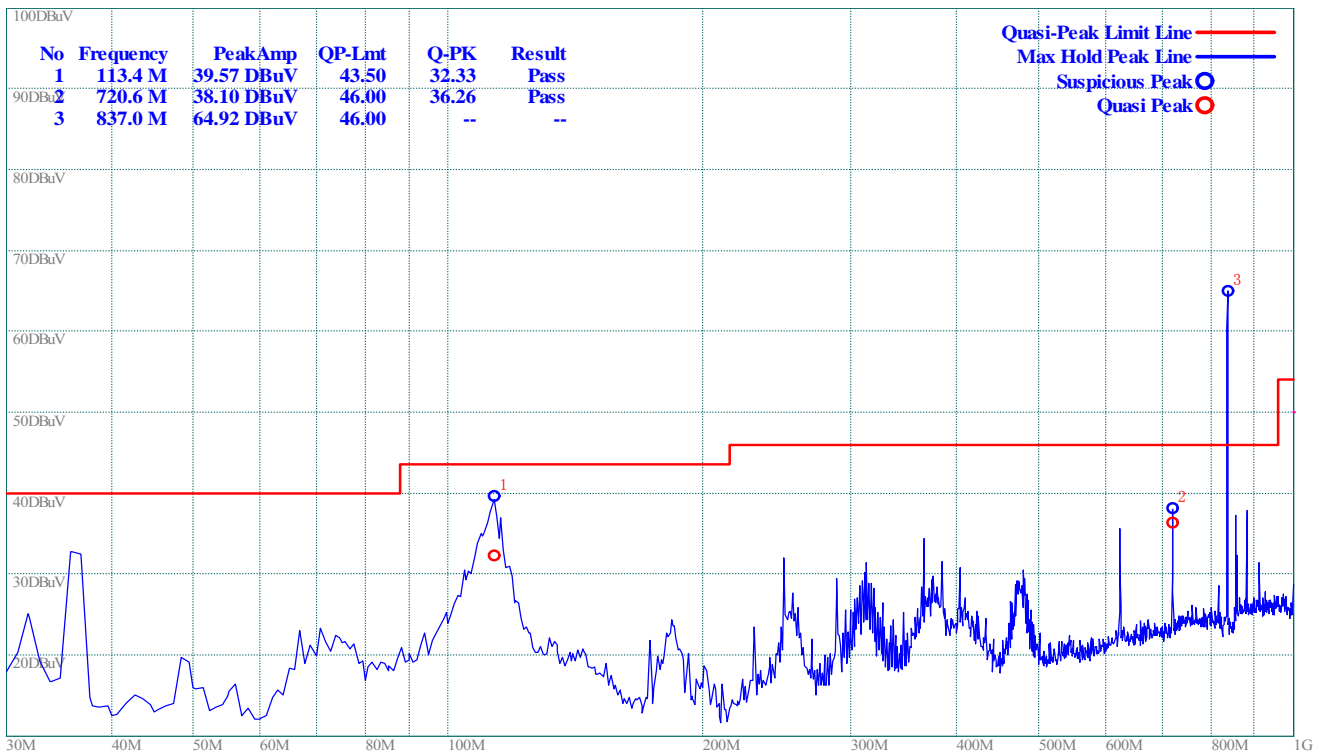
4.2.3.1 CDMA1X Test Mode

A. Test Plot And Suspicious Points:

Note: "--" in the plot below means that the emission was the signal of the CDMA1X.



(Plot A: Test Antenna Vertical)



(Plot B: Test Antenna Horizontal)

** END OF REPORT **